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APPLICANT

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## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLAS	SUB- CLASS	FILING DATE
		FOREIGN PAT	TENT DOCUMENTS	S		
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO PART.

**OTHER REFERENCES** (Including Author, Title, Date, Pertinent Pages, Etc.)

C. SETIAGUNG et al., "Very Low Threshold Current Density of 1.3 μm-range GalnNAsSb/GaNAs 5QWs Lasers", The Furukawa Electric Co., Ltd., Yokohama R&D Laboratories, © 2002, IEEE, pgs. 39-40
E. GOUARDES et al., "GalnAs-GalnNAs-GalnAs Intermediate Layer Structure for Long Wavelength Lasers", <i>IEEE PHOTONICS TECHNOLOGY LETTERS</i> , vol. 14, No. 7, July 2002, pgs. 896-898
M. KAWAGUCHI et al., "Photoluminescence and Lasing Characteristics of 1.3µm GalnNAs/GaAsP/GaAs Strain-compensated Quantum Wells", <i>Compound Semiconductors</i> 2003, International Symposium, August 25-27, 2003, pgs. 72-73
DATE CONSIDERED

citation if not in conformance and not considered. Include copy of this form with next communication to applicant.